



Resolution studies with the DATURA beam telescope

An iterative pull analysis

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The DATURA beam telescope

- Usually used in sensor R&D
- Located at DESY TB hall 21
- 6 Mimosa26 sensors
- NI-based DAQ system
- EUDET Trigger Logic Unit
 - Input: 4 scintillators
 - Output: Trigger to DAQ systems
- Available: x-y-phi stage for Device Under Test (DUT)
- Connect multiple DUTs or additional reference sensors
 - → Measure the *intrinsic resolution* of Mimosa26 themselves
 - → Predict/Optimise set-up dependent track resolution





Mimosa 26 pixel sensors

- AMS 350 nm CMOS
- 18.4 um x 18.4 um
- 1152 x 576 pixels
- Roughly 10 mm x 20 mm



- Thickness: specs 50 um, measurement (55 ± 3) um
- HR epitaxial layer of 20 um thickness
- Binary resolution 5.3 um, improved by charge sharing
- Protected by 25 um Kapton on each side
- Material budget of sensor plus Kapton: $\varepsilon = 7.5e-4$



Measurement geometries

- Plane spacing dz = 20 mm (narrow) or 150 mm (wide)
- Total material budget: 4.8e-3 and 7.0e-3, respectively



Data analysis flow

- Analysis done with EUTelescope
- Start with Mimosa26 data
- Hot pixel search



- Cluster formation, remove clusters with hot pixels
- Track triplets built for up- and downstream plane trio
- Isolation cut on triplets
- Match up- and downstream triplets in the centre \rightarrow *six-tuple* belonging to a physical track
- Feed six-tuple to Millepede for alignment using *estimates on measurement resolution* (multiple times if needed)





GBL tracking

- General Broken Lines allows for kinks at scatterers
- Calculating corrections to an initial simple seed track
- Average deflection predicted by Highland:

$$\Theta_{0} = \frac{13.6 \,\mathrm{MeV}}{\beta c p} \cdot z \sqrt{\varepsilon} \cdot (1 + 0.038 \ln{(\varepsilon)})$$



- Perform χ^2 minimisation to find track parameters
- Track model does not include bremsstrahlung, non-Gaussian tails or non-linear effects
- Inputs: *Measurement* + *error*, geometry, scattering estimate
- Outputs: residual + error, res. width estimate, kinks, track resolution

V. Blobel, C. Kleinwort, and F. Meier. Fast alignment of a complex tracking detector using advanced track models. Computer Physics Communications, 182(9):1760 – 1763, 2011.

C. Kleinwort. General broken lines as advanced track fitting method. Nucl. Instr. Meth. Phys. Res. A, 673:107–110, May 2012.



Biased residuals and pulls

- Biased residual = (measurement fit) including all 6 planes
- Normalise residual by expected residual width

$$\text{pull}_{\text{b}} \equiv p_{\text{b}} = \frac{r_{\text{b}}}{\sqrt{\sigma_{\text{int}}^2 - \sigma_{\text{t},\text{b}}^2}} - \text{Predict using GBL}$$

- Pull is N(0,1) if
 - estimate for intrinsic resolution matches true value
 - material budget and scattering is accurately described
 - \rightarrow **Iterate** track fit with updated σ_{int} and $\sigma_{t,b}$ using the pull width
 - \rightarrow pull_b \rightarrow N(0,1) and σ_{int} converges against true value
 - \rightarrow Use results from narrow and wide set-up for cross validation



Biased residuals II





Biased residuals III



 \rightarrow Average intrinsic resolution: $\sigma_{M26} = (3.24~\pm~0.09)~\mu m$



Systematics

• Estimate systematic uncertainties of intrinsic resolution based on the input uncertainties

			$\sigma_{\sigma_{ m int}}$ in %				
			per plane			all planes	$\sqrt{\sum (x_i)^2}$
			E	Θ_0	fit range	$ m rms(p_b)$	
10 - 10 - 10 - 10 - 10 - 10 - 10 - 10 -			$\pm5\%$	$\pm 3\%$	$\pm 1 \text{std.}$		
$6{ m GeV}$	$20 \mathrm{~mm}$	biased	-0.34 + 0.21	$+0.08 \\ -0.28$	$^{+1.76}_{-1.27}$	1.57	2.6
		unbiased	-0.43 + 0.71	$^{+0.44}_{-0.25}$	$-0.93 \\ -1.00$	1.23	1.8
	$150 \mathrm{~mm}$	biased	-3.5 + 2.9	$^{+1.95}_{-2.60}$	$+6.4 \\ -5.4$	1.51	7.9
		unbiased	$-4.80 \\ +5.43$	$^{+2.97}_{-4.13}$	$-5.29 \\ +3.11$	0.75	8.7
$2{ m GeV}$	$20 \mathrm{~mm}$	biased	-1.56 + 1.13	$^{+0.65}_{-1.22}$	$^{+0.23}_{+0.33}$	3.1	3.7
		unbiased	$^{-1.67}_{+1.21}$	$^{+0.92}_{-1.10}$	-2.15 + 1.35	1.94	3.1
	$150 \mathrm{~mm}$	biased	-10.5 + 15.7	$^{+10.2}_{-6.59}$	$^{+8.0}_{+0.82}$	0.82	20.3
		unbiased	-17.5 + 24.9	$^{+14.9}_{-15.2}$	$-23.9 \\ +25.1$	1.03	38.5



Threshold dependency



Towards higher threshold: → cut signal

- → smaller clustersize
- → worse resolution

Towards lower threshold: → more noise hits → worse resolution

→ Optimum at threshold 5 to 6



Track resolution predictions

• Using 6 planes, assuming DUT in the centre





Track resolution predictions

Using 6 planes, assuming DUT in the centre **10** 10 9 track resolution at z_{DUT} [μ m] track resolution at DUT [µm] p = 5 GeV€**M26** 9 p = 5 GeV8 5 6 4 5 3 4 dz = 150 mm20 mm dz = 20 mmdz = 150 mm3 2 ∈рит ∈рит dz_{DUT} dz 0.03 ----- 0.03 20 mm 20 mm 0.01 60 mm 60 mm -.003 0.003 (A)100 mm — 100 mm 0.001 - 0.001 . . . | . . . | . 100 120 140 160 180 200 0.001 0.002 0.02 0.01 dz_{DUT} [mm] €DUT \rightarrow dz_{DUT} as small as possible \rightarrow Thick DUT: use wide set-up Thin DUT: use narrow set-up



Looking even closer ...

Fold occurrence into one pixel for intra-pixel studies



- → Frequency of occurrence is position dependent
- → Populated areas differ in size
- → Resolution is CS dependent
 - → Calculate differential intrinsic resolution





4 6 8

10 12 14 16 18 GBL track x at plane3 [μm] 4 6 8 10

2

12 14

GBL track x at plane3 [µm]

16 18

CS-dependent quantities

- Repeat iterative pull method for each clustersize
 - \rightarrow differential intrinsic resolution
- Resulting $\sigma_x vs x$ within a pixel per clustersize:





CS-dependent quantities

- Repeat iterative pull method for each clustersize
 - \rightarrow differential intrinsic resolution
- Resulting σ_x vs x within a pixel per clustersize:



Conclusion

- Performed in-depth resolution study of DATURA
- Very precise tool (few um track res.) for sensor R&D
- Iterative pull analysis:

→ Avg. intrinsic resolution σ_{M26} = 3.24 um at threshold 6

- Repeat for different clustersizes:
 - → Differential intrinsic resolution, can be used as CS-dependent input during tracking
- Recommendation to users:
 - → Use track resolution predictions for optimisation of test beam set-up

Some of these results have recently been published at EPJ Techniques & Instrumentation: *Hendrik Jansen, et al., "Performance of the EUDET-type beam telescopes", in press.*



Next Beam Telescope and Test Beam Workshop

BARCELONA

January $24^{th} - 27^{th}$, 2017

cern egroup: BeamTelescopesAndTestBeams-Announcements@cern.ch

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Back-up



Offline analysis and reconstruction

- EUTelescope is based on the ILCSoft framework:
 - generic data model (LCIO)
 - geometry description (GEAR)
 - central event processor (Marlin)
- Marlin allows for modular composition of analysis chain
- Build-in job submission framework
- Steering of analysis via XML files loaded at runtime
- EUTelescope provides processors for full track reco including:
 - Alignment with Millepede-II
 - General Broken Lines track fitter
 - many more



Multiple scattering

• Average deflection predicted by Highland

$$\Theta_{0} = \frac{13.6 \,\mathrm{MeV}}{\beta c p} \cdot z \sqrt{\varepsilon} \cdot (1 + 0.038 \ln{(\varepsilon)})$$

- Literature offers other models, too, HL most popular
- Distribution assumed to be Gaussian centrally
- Non-Gaussian tails
- MS and intrinsic resolution defines track resolution, i.e. uncertainty in space of a track along the track



Track cleaning

- Cut on tracks: prob < 0.01 (0.1) for 20 mm (150 mm)
 model less valid for larger amount of material budget
- Use robust statistics (down-weighting of out-layers) only if you don't have enough data (and if you know what you are doing)
- If track collection is not cleaned, "bad" tracks affect the GBL fit probability
 GBL fit probability
 gblprb



Prob biased vs unbiased





Residuals

- Residual = Measurement Fit
- Biased (use all measurements) and unbiased (leave one out) tracks are different!



• Use track fits for residual and pull distribution

$$r_{\rm u}^2(z) = \sigma_{\rm int}^2(z) - \sigma_{\rm t,b}^2(z)$$

$$r_{\rm u}^2(z) = \sigma_{\rm int}^2(z) + \sigma_{\rm t,u}^2(z)$$



Pulls

• Normalise residual by expected residual width

$$\text{pull}_{\text{b}} \equiv p_{\text{b}} = \frac{r_{\text{b}}}{\sqrt{\sigma_{\text{int}}^2 - \sigma_{\text{t,b}}^2}}$$

- Pull is N(0,1) if
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 - \rightarrow **Iterate** track fit with updated σ_{int} using the pull width
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Pulls and track resolution

• Normalise residual by expected residual width

$$\text{pull}_{\mathbf{u}} \equiv p_{\mathbf{u}} = \frac{r_{\mathbf{u}}}{\sqrt{\sigma_{\text{int}}^2 + \sigma_{\text{t,u}}^2}}$$

Pull is N(0,1) if

- estimate for intrinsic resolution matches true value
- material budget is accurate
- deflection due to multiple Coulomb scattering is accurately described
- \rightarrow repeat track fit varying σ_{int} by pull width
- \rightarrow pull \rightarrow N(0,1) and σ_{int} converges



Pulls and track resolution II







→ Increase σ_{int} by 6%, re-fit the tracks



Pulls and track resolution III

• Residual estimate as function of intr. resolution:



- Systematics affect unbiased track reso. relatively equal
- But $\sigma_{t,b} < \sigma_{t,u}$

$$\text{pull}_{\text{b}} \equiv p_{\text{b}} = \frac{r_{\text{b}}}{\sqrt{\sigma_{\text{int}}^2 - \sigma_{\text{t,b}}^2}}$$

- → absolute error smaller
- \rightarrow what about the residual?



Intrinsic resolution

- The iterative method converges i.e. estimator for $\sigma_{\mbox{\scriptsize int}}$ converges against the true value
- We find energy independent value of

 $\sigma_{int} = 3.24 + 0.5\%$ (stat.) + - 3% (syst.) (cf.last slide)

- Control sys. uncert. further by comparing set-ups
- Increases for lower thresholds (more noise hits)
- Increases for higher thresholds (smaller clusters)
- Optimum is 5 6, probably a tune of 5.5



Track resolution predictions

- Using 6 planes, assuming DUT in the centre
- Wide set-up offers superior track resolution with thicker DUTs and vice versa.
- Intersection is function of material budget
 - → Optimise resolution prior to your test beam





Looking even closer ...



DES



CS-dependent quantities

- Repeat iterative pull method differentially for each clustersize
 → differential intrinsic resolution
 - Resulting σ_x vs x within a pixel per clustersize:

CS1: 3.60 μm CS2: 3.16 μm CS3: 2.86 μm CS4: 3.40 μm CS5: 2.53 μm CS6: 2.70 μm CS>6: 4.17 μm





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